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#### 1. 概述 Scope:

#### 1.1 说明 Content

此份产品规格书是针对由昆山嘉华电子有限公司设计和制造的 **USB TYPE C 3.113A\***产品 所定义的产品性能和测试方法。

This product specification defines the product performance and the test methods to ensure the performance of the <u>USB TYPE C 3.113A\*</u>, which is designed and manufactured by Kunshan Jiahua Electronics Co., Ltd.

#### 1.2 限制 Qualification

所有的测试和检验必须依照本文件中所要求的规格、方法进行。一旦产品的重要制程发生 变更,必须立即进行品质验证和测试。

Tests and inspection shall be performed in accordance with the requirements, tests and methods contained herein. A re-qualification test shall be conducted immediately following all major process changes.

#### 2. 参考文件 Referenced Documents: EIA-364

若某些项目被发现本规格书中的内容与以上参考文件要求不一致时,一律依本规格书中的内容为测试依据。

In case of any contradiction between this document and referenced documents, this document will take precedence.

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#### 3. 规格要求 Requirements:

3.1 应用条件 Application Condition:

3.1.1 额定电流Current Rating: VBUS AND GND CONTACTS RATED AT 2.5A, PARALLELED FOR A TOTAL OF 7.5A.(平行时总共电流7.5A) 其它PIN POWER:0.25A.

3.1.2. 额定电压 Voltage Rating: 30V AC Max.

3.1.3 使用环境 Operating Environment:

温度: -40°C to +85°C,相对湿度:15%~85%,此条件下功能不可失效。

Temperature:-40°C to +85°C, Relative Humidity:15%~85%, Without loss of function.

3.1.4 储存环境 Storage Environment:

温度: -40°C to +100°C,相对湿度:95%或更低,此条件下功能不可失效。

Temperature:-40°C to +100°C, Relative Humidity: 95% or Less, Without loss of function.

3.2 绿色环保要求 Health, Safety and Environment

此产品中所有涉及环保有关的有害物质管控标准请参考嘉华系统文件:JH-GP-213

Hazardous substances (Environment related to be controlled substances) contained in this product should comply with the regulations specified by FAF's <u>JH-GP-213</u>.

3.3 测试说明 Test Description

此产品性能须满足本文件 **3.4** 节中的各项规格要求。除非有特别申明,所有的测试和量测必须在以下条件中进行:

The product is designed to meet the requirements specified in section 3.4. Unless otherwise specified, all tests and measurements are to be performed under the following conditions:

温度 Temperature: 15℃~35℃

相对湿度 Relative Humidity: 20% to 70%

大气压 Atmospheric Pressure: 650 to 800 millimeters (25.6 to 31.5 inches) of Mercury.

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3.4 测试规范和力	方法 Test Requirements and Method	S
 Table I: 性能要求 Per	formance Requirements	
项目 Items	规格要求 Requirements	测试方法 Test Methods
3.4.1 产品外观	目视和其他合适的仪器检测产品的外观 结构及尺寸满足图面要求	参考测试标准: EIA-364-18 依照相应的文件和规格书进行外观,功能,及尺寸的 检验量测.
Visual Examination	Check that appearance $\$ construction and dimension of connector are in accordance with drawing by eyes and suitable instruments.	Comply with method EIA-364-18 Appearance, functional, and dimensional inspection complies with applicable specification and document.
3.4.2 SMT 产品耐 Reflow 高温	外观: 良好	300℃ MAX260℃,10sec Min
Withstand Temperature For SMT type.	Appearance: Good	200°C 100°C 100°C 150~190°C,60~120sec 150~190°C,60~120sec 150~120sec
		IR 1 次 For IR one time.
3.4.3 低功率接触阻抗 Low Level Contact	初始接触阻抗: 40mΩ Max. 测试后接触阻抗: 40mmΩ Max;.	参考测试标准: EIA-364-23 必须保证量测结果为产品以及与之对应配对产品 的焊接部位之间的阻抗值;
Resistance	Initial: $40m\Omega$ Max; After Test: $40mm\Omega$ Max;	Comply with method EIA-364-23. with the exception of the resistance readings, which shall be measured between the termination points of tested plug and connector
3.4.4 绝缘阻抗	100 MΩ Min.	参考测试标准: EIA-364-21. 使用 500V 直流电压 1Min± 5 秒,在相邻两端子 或接地片之间
Insulation Resistance		Comply with method: EIA-364-21 Apply a voltage 500VDC 1Min± 5 Sec. between adjacent terminals or between terminal and ground.

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3.4.5 耐电压 Dielectric Withstanding Voltage		参考测试标准: EIA-364-20; 使用交流 100V 的电压(测试后使用 250V 的电压) 在相邻两端子或接地片之间保持 1 分钟+/-5 秒 Comply with method: EIA-364-20 Apply a voltage 100VAC(apply 250V AC After test) for 1 Min± 5Sec between adjacent terminals or between terminals to ground.
3.4.6 温度上升 Temperature rise	将样品与插头连接,电源和信号 端子分别通过测试额定电流, 记录3 小时后的温度上升情况. Mated and measure the temperature rise of contact when the rated current is passed after 3 hours.	温度上升 30℃Max. Temperature rise: 30℃Max.

# Kunshan Jiahua Electronics Co., Ltd. 文件名称 System Name・ デロロケー

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项目 Items	规格要求 Requirements	测试方法 Test Methods
3.4.7	1.测试后接触阻抗: 40mΩ Max;.	参考测试标准: EIA-364-28,
振动	2. 瞬断 : 1 u sec Max.	测试电流: 100mA. 每个方向振动 2H,
		振幅:1.5mm, 频率每分钟 10-55-10HZ
Vibration		Comply with EIA-364-28
	1. After Test: $40 \text{m} \Omega$ Max;	Current of 100mA shall be applied during the
	2. Discontinue:1u sec Max.	testing. The vibration shall be along each axis
		for the period of two hours with the max amplitude of 1.5mm and frequency of 10-55-
		10HZ/Min
3.4.8	不产生超过 lu 秒的瞬断, 产品没有物理	参考测试标准: EIA-364-27 Condition A
机械冲击	破坏以及零件脱落,端子接触阻抗满足规	加速度: 50G;波形:半正弦冲击波;时间:
	格要求.	11 毫秒;正反三个相互垂直方向各冲击3
Physical Shock		次,共18次.
	No electrical discontinuity longer than 1u	Comply with EIA-364-27 Condition B
	sec. No mechanical damage or looseness,	Duration Pulse : 11 msec.,
	contact resistance specifications remain	Wave form : half sine, 50G, Both direction of
	satisfied.	mutually perpendicular axes. Total 18 shocks
3.4.9	外观无任何损坏	参考测试标准: EIA-364-09;
耐久插拔	Appearance: no damage	以最大每小时 500 次的速度连
D 1114	耐久后接触电阻值:最大40mΩ.	续插拨公母座10000次
Durability	After test contact	Mate/un-mate up to 10000 cycles
	resistance: 40mΩ Max.	repeatedly at Max. speed of 500
	插入力: 5~20N	cycles/hr.
	Mating Force: 5~20N	5
	拨出力: 8~20N (1000 次)	
	Un-mating Force: 8~20N	
	(1000cycles)	
	拨出力: 6~20N (10000 次)	
	Un-mating Force: 6~20N	
	(10000cycles)	
3.4.10		参考测试标准: EIA-364-13.
插入力/拔出力	拔出力 8N~20N	测试过程中产品运动速度:每分种 12.5mm
Mating force&	Insertion Force 5N~20N	Comply with method EIA -364-13.
Un-mating force	Withdrawal Force 8N~20N	Connector mated/unmated at maximum rate of
		12.5 mm per minute.

### Kunshan Jiahua Electronics Co., Ltd. 文件夕称 System Marrie

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项目 Items	规格要求 Requirements	测试方法 Test Methods					
3.4.11	1. 测试后接触阻抗: 40mΩ Max.	参考测试标准: EIA-364-26					
盐雾实验	2. 外观:良好	盐水温度: 35±2℃,浓度 5±1%,时间: 48 小时.					
		Comply with method EIA-364-26. Salt solution					
Salt Spray	1. After the test LLCR: $40m\Omega$ Max.	temperature $35\pm2^{\circ}$ C, Concentration $5\pm1\%$ ,					
	2. Appearance: Good	Duration: 48H.					
3.4.12	产品外观无损伤	参考测试标准: EIA-364-32C					
热冲击测试	Appearance: no damage	将样品与插头连接,按如下条件置于					
Thermal Shock	测试后接触电阻在最大40 mΩ	以下环境循环5次,结束后,将测试					
	After testing contact resistance:	样品置于常温下恢复1~2小时后进行					
	$40\mathrm{m}\Omega$ Max.	测试;					
	绝缘电阻最小100MΩ	-55 +0/-3℃ 30分钟					
	Insulation resistance: $100M\Omega$	25 ±10 ℃ 5分钟					
	Min.	+85 +3/-0℃ 30分钟					
		25±10℃ 5分钟					
3.4.13	产品外观无损伤	参考测试标准: EIA-364-31B					
高温高湿循环	Appearance: no damage	相对湿度 95~100%					
High temperature	测试后接触电阻在最大40 mΩ	温度和时间:					
&High	After testing contact resistance:	25~55℃ 3 小时>					
Humidity Cycle	$40\mathrm{m}\Omega$ Max.	55℃ 9小时>					
	绝缘电阻最小100MΩ	55~25°C 3 小时>					
	Insulation resistance: $100M\Omega$	25℃ 9 小时					
	Min.	25 C 7 (14)					
3.4.14	外观无任何损坏	参考测试标准: EIA-364-17					
温度寿命测试	Appearance: no damage;	将样品置于105±2℃下120 小					
Temperature life	测试后接触电阻:最大40mΩ下.	时,结束后,将测试样品置于常					
	After test contact resistance:	温下 1~2 小时后进行测试;					
	$40\mathrm{m}\Omega$ Max.						
	绝缘电阻:最小100MΩ以上						
	Insulation resistance: $100M\Omega$						
1	Min.						
3.4.15	焊接部位吃锡面积在95%以上	参考测试标准: EIA-364-52					
		多气测试标准.EIA-504-52 将焊锡部分尾部浸到融化的锡炉里,温度					
焊锡性	The termination is at least 95%	将厈扬部万尾部反到配位的物炉里,温度 245±5℃,4~5秒					
Solderability	Covered by a continuous solder coating.	Comply with method EIA-364-52					
		Dip solder tails into the molten solder held					
1		at $245\pm5^{\circ}$ C for $4\sim5$ seconds.					

### Kunshan Jiahua Electronics Co., Ltd. 文件名称 Suptor No.

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项目 Items	规格	要求 Requirements				测试方法 Test Methods							
测试项目 Test Item		群组测试 Test Group											
		А	В	С	D	Е	F	G	Н	Ι	J	K	
产品外观 Visual Examination		1,7	1,8	1,8	1,4	1,6	1,7	1,6	1,3				
低功率接触阻抗 Contact Resistance Low Level		3,6	3,7	3,5		3,5	3,5	3,5					
绝缘阻抗 Insulation Resistance				6			6						
耐电压 Dielectric Withstanding Voltage				7									
温度上升 Temperature Rise					3								
插拔耐久 Durability			5										
振动 Vibration		5											
机械冲击Shock (Mechanical)		4											
插拔力 Mating/Unmating Forces			4,6										
热冲击测试Thermal Shock				4									
盐雾腐蚀 Salt Spray								4					
高温高湿循环High temperature&High Humidity Cycle							4						
温度寿命测试Temperature life						4							
焊锡性Solderability									2				
SMT 产品耐 Reflow 高温 Withstand For SMT type.	Temperature	2	2	2	2	2	2	2					
Sample Size*		5	5	5	5	5	5	5	5				